## Notice of References Cited Application/Control No. 10/788,702 Examiner LEE D. WILSON Applicant(s)/Patent Under Reexamination CHEN ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,422,927 B1	07-2002	Zuniga, Steven M.	451/288
*	В	US-6,540,595 B1	04-2003	Birang, Manoocher	451/288
*	С	US-6,379,230 B1	04-2002	Hayashi et al.	451/292
*	D	US-6,623,333 B1	09-2003	Patel et al.	451/9
*	Е	US-6,776,692 B1	08-2004	Zuniga et al.	451/41
*	F	US-2005/0191942 A1	09-2005	Chen et al.	451/005
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	٠м	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.